

Search Notes

Application/Control No.

10/770,119

Examiner

Toan M. Le

Applicant(s)/Patent under
Reexamination

KADABA, NAGESH

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	184	5/19/2005	TL
340	572.1	5/19/2005	TL
340	539	5/19/2005	TL
340	988	5/19/2005	TL
705	28	5/19/2005	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
RFID Environment Track Scan Sensor	5/19/2005	TL
Environment Sensor, Scan, Tag, Transport	5/19/2005	TL
Environment Sensor, Scan, Track, Monitor, Transport	5/19/2005	TL
East, Web, and NPL search		